

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: PETER GROZ	§	Attorney Docket No. HSJ920030143US1
	§	
	§	
Serial No.: Not yet assigned	§	Examiner: Not yet assigned
	§	
Filed: Not yet assigned	§	
	§	
For: METHOD FOR PERFORMING	§	Art Unit: UNKNOWN
TESTING OF A SIMULATED	§	
STORAGE DEVICE WITHIN A	§	
TESTING SIMULATION	§	
ENVIRONMENT	§	

INFORMATION DISCLOSURE STATEMENT
PURSUANT TO 37 C.F.R. § 1.97(b)

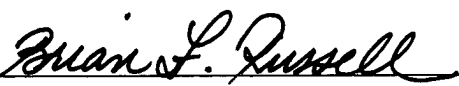
Commissioner for Patents
PO Box 1450
Alexandria, Virginia 22313-1450

Sir:

Applicants request that the information listed on the attached (Substitute) Form PTO-1449 be considered by the Office during the pendency of the above-entitled application, pursuant to 37 C.F.R. § 1.97. This Information Disclosure Statement is being filed under 37 C.F.R. § 1.97 (b) within three months of the filing date of the application, or before the mailing date of a first office action on the merits. No fee or certification is required.

No fee is believed to be necessary; however, in the event that any fee is required, please charge it to **HITACHI Global Storage Technologies Deposit Account Number 50-2587**.

Respectfully submitted,



Brian F. Russell
Registration No. 40,796
BRACEWELL & PATTERSON, L.L.P.
P.O. Box 969
Austin, Texas 78767-0969
(512) 472-7800
ATTORNEY FOR APPLICANT

Substitute form 1449/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Complete if Known		
				Application Number	UNKNOWN	
				Filing Date	HEREWITH	
				First Named Inventor	PETER GROZ	
				Group Art Unit	UNKNOWN	
				Examiner Name	NOT YET ASSIGNED	
Sheet	1	of	1	Attorney Docket Number	HSJ920030143US1	
U.S. PATENT DOCUMENTS						
Examiner Initials	IDS Doc #	U.S. Patent Document Number	Name of Patentee or Applicant		Publication Date MM-DD-YYYY	
	AA	US 6,353,898 B1	Robert A. Wipfel et al.		03-05-2002	
	AB	US 6,182,248 B1	Cynthia Joan Armstrong et al.		01-30-2001	
	AC	6,167,479	Thomas D. Hartnett et al.		12-26-2000	
	AD	5,841,960	Takeshi Ibusuki et al.		11-24-1998	
	AE	5,699,502	Randal Craig Swanberg et al.		12-16-1997	
	AF	5,671,352	Ramesh Subrahmaniam et al.		09-23-1997	
	AG	5,475,624	Burnell G. West		12-12-1995	
	AH	5,428,624	Larry D. Blair et al.		06-27-1995	
	AI	5,425,036	Dick L. Liu et al.		06-13-1995	
	AJ	5,146,460	Dennis F. Ackerman et al.		09-08-1992	
	AK	5,130,988	Philip S. Wilcox et al.		07-14-1992	
	AL	5,008,885	Kevin C. Huang et al.		04-16-1991	
	AM	4,999,837	Frank S. Reynolds et al.		03-12-1991	
	AN	4,759,019	Paul C. Bentley et al.		07-19-1988	
FOREIGN PATENT DOCUMENTS						
Examiner Initials	IDS Doc #	Office	Foreign Patent Document No.	Name of Patentee or Applicant	Date of Publication	English Translation
	AO		EP0376034A2	International Business Machines Corporation	07-04-1990	Yes
OTHER PRIOR ART – NON PATENT LITERATURE DOCUMENTS						
Examiner Initials	IDS Doc #	Include the name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published				English Translation
	AP	J.W. ECKEL, R.E. FLOYD, J.C. MAHLBACHER AND R.C. STANLEY, "Large System Diagnostics with Minimal Hardware", IBM Technical Disclosure Bulletin, April 1989, Vol. 31, No. 11, pages 367-369				English
	AQ	Z. BARZILAI, J.L. CARTER, L.M. HUISMAN, E. KRONSTADT, B.K.ROSEN AND J.D. RUTLEDGE, "Fault Simulation on the YSE/EVE" IBM Technical Disclosure Bulletin, July 1985, Vol. 28, No. 2, pages 773-776				English
	AR	I. CHIRASHNYA, G. MACHULSKY, R. ROSS AND LEAH SHALEV, "Error Injection Apparatus and Method", IBM, September 8, 1999				English
	AS	HELMUT KOHLER, ANDREAS EISENHOFER, HARALD FISCHERL AND NORBERT SCHUMACHER, "IML – Stream Generated Error Insertion/FRU Isolation", IBM, January 3, 2002				English
Examiner Signature					Date Considered	

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.